

<b>REFERENCES FOR EX PARTE REEXAMINATION IN PTO-1449 FORM</b>	Atty. Docket No. 020697RE	Patent No. 5,074,456
	Inventor(s): Raymond Degner et al.	
	Filing Date: September 18, 1990	

### U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
JP	4,340,462	Koch	Jun/20/82	204	298	

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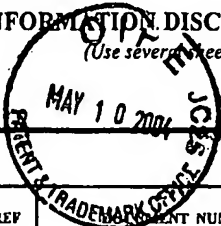
Examiner Initial	Document No.	Date	Country	Translation (Yes or No)
JP	61-279672 A1	Dec/10/86	JP	Yes
JP	61-243170 A1	Oct/29/86	JP	Yes
JP	01-204424 A1	Aug/17/89	JP	Yes
JP	61-120758 U1	Jul/30/86	JP	Yes (partial)
JP	61-291967 A1	Dec/22/86	JP	Yes (partial)
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### OTHER DOCUMENTS

Examiner Initial	Document	Date	Translation (Yes or No)
JP	McGraw-Hill Dictionary of Scientific and Technical Terms, page 694.	2003	N/A
JP	The Penguin Dictionary of Electronics, page 167. <del>4-11-1998</del>	1998	N/A
Examiner	Date Considered 11/7/08		

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)

01-9665-06

Application Number

10/734,073

Applicant(s)

Degner et al.

Filing Date

Dec. 12, 2003

Group Art Unit

Unknown

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JP	A	4,386,979	5/31/83	Pierce et al.	204	298	
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	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
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EXAMINER

*John R.*

DATE CONSIDERED

11/7/05

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Substitute for forms 1449A/PTO &amp; 1449B/PTO

# **FIRST INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

ATTORNEY'S DKT NO.  
015290-795

APPLICATION NO.  
(unassigned)

APPLICANT  
Raymond DEGNER et al.

FILING DATE  
December 12, 2003

GROUP

## **U.S. PATENT DOCUMENTS**

Examiner Initials	Document Number	Kind Code (if known)	Name of Patentee or Applicant of Cited Document	Issue/Publication Date (MM-DD-YYYY)
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	4,209,357		Gorin et al.	06-24-1980
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## **NON-PATENT LITERATURE DOCUMENTS**

Examiner Initials	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	Official Letter from Taiwanese National Bureau of Standards for TW Patent Application No. 80101614

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Examiner Initials	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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